

Test Report

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LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : SURFACE MOUNTED ELECTRONIC DEVICE
Style/Item No. : SOD SERIES (SOD-323, SOD-523, SOD-882, SLP1006P3 (SOD-883))
Sample Receiving Date : 2010/07/27
Testing Period : 2010/07/27 TO 2010/08/03

=====
Test Result(s) : Please refer to next page(s).



Chenyu Kung / Operation Manager
Signed for and on behalf of
SGS TAIWAN LTD.
Chemical Laboratory – Taipei

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Test Result(s)

PART NAME NO.1 : MIXED ALL PARTS (4 TYPES)

Test Item (s):	Unit	Method	MDL	Result
				NO.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Mercury (Hg)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Hexavalent Chromium Cr(VI) by alkaline extraction	mg/kg	With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n.d.
Antimony (Sb)	mg/kg	With reference to US EPA Method 3050B for Antimony Content. Analysis was performed by ICP-AES.	2	n.d.
Perfluorooctane sulfonates (PFOS) PFOS – Acid PFOS – Metal Salt PFOS – Amide	mg/kg	With reference to US EPA 3540C: 1996 method for PFOS Content. Analysis was performed by LC/MS.	10	n.d.
PFOA (CAS No.: 000335-67-1)	mg/kg	With reference to US EPA 3540C: 1996 method for PFOA Content. Analysis was performed by LC/MS.	10	n.d.
Halogen				
Halogen-Fluorine (F) (CAS No.: 014762-94-8)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
Halogen-Chlorine (Cl) (CAS No.: 022537-15-1)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
Halogen-Bromine (Br) (CAS No.: 010097-32-2)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
Halogen-Iodine (I) (CAS No.: 014362-44-8)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.

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Test Item (s):	Unit	Method	MDL	Result
				NO.1
Sum of PBBs	mg/kg	With reference to IEC 62321: 2008 and performed by GC/MS.	-	n.d.
Monobromobiphenyl			5	n.d.
Dibromobiphenyl			5	n.d.
Tribromobiphenyl			5	n.d.
Tetrabromobiphenyl			5	n.d.
Pentabromobiphenyl			5	n.d.
Hexabromobiphenyl			5	n.d.
Heptabromobiphenyl			5	n.d.
Octabromobiphenyl			5	n.d.
Nonabromobiphenyl			5	n.d.
Decabromobiphenyl			5	n.d.
Sum of PBDEs			-	n.d.
Monobromodiphenyl ether			5	n.d.
Dibromodiphenyl ether			5	n.d.
Tribromodiphenyl ether			5	n.d.
Tetrabromodiphenyl ether			5	n.d.
Pentabromodiphenyl ether			5	n.d.
Hexabromodiphenyl ether			5	n.d.
Heptabromodiphenyl ether			5	n.d.
Octabromodiphenyl ether			5	n.d.
Nonabromodiphenyl ether			5	n.d.
Decabromodiphenyl ether			5	n.d.

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Test Item (s):	Unit	Method	MDL	Result
				NO.1
Polynuclear Aromatic Hydrocarbons (PAHs)				
Acenaphthene (CAS No.: 000083-32-9)	mg/kg	With reference to ZLS standard ZEK 01.2-08 method. Analysis was performed by GC/MS.	0.2	n.d.
Acenaphthylene (CAS No.: 000208-96-8)			0.2	n.d.
Anthracene (CAS No.: 000120-12-7)			0.2	n.d.
Benzo[a]anthracene (CAS No.: 000056-55-3)			0.2	n.d.
Benzo[a]pyrene (CAS No.: 000050-32-8)			0.2	n.d.
Benzo[b]fluoranthene (CAS No.: 000205-99-2)			0.2	n.d.
Benzo[g,h,i]perylene (CAS No.: 000191-24-2)			0.2	n.d.
Benzo[k]fluoranthene (CAS No.: 000207-08-9)			0.2	n.d.
Chrysene (CAS No.: 000218-01-9)			0.2	n.d.
Dibenzo[a,h]anthracene (CAS No.: 000053-70-3)			0.2	n.d.
Fluoranthene (CAS No.: 000206-44-0)			0.2	n.d.
Fluorene (CAS No.: 000086-73-7)			0.2	n.d.
Indeno[1,2,3-c,d] pyrene (CAS No.: 000193-39-5)			0.2	n.d.
Naphthalene (CAS No.: 000091-20-3)			0.2	n.d.
Phenanthrene (CAS No.: 000085-01-8)			0.2	n.d.
Pyrene (CAS No.: 000129-00-0)			0.2	n.d.
Sum of 16 PAHs	-	n.d.		

Note :

1. mg/kg = ppm ; 0.1wt% = 1000ppm
2. n.d. = Not Detected
3. MDL = Method Detection Limit
4. " - " = Not Regulated
5. The sample(s) was/were analyzed on behalf of the applicant as mixing sample in one testing. The above result(s) was/were only given as the informality value.

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PFOS Reference Information : Directive 2006/122/EC

(1) May not be placed on the market or used as a substance or constituent of preparations in a concentration equal to or higher than 0.005 % by mass.

(2) May not be placed on the market in semi-finished products or articles, or parts thereof, if the concentration of PFOS is equal to or higher than 0.1 % by mass calculated with reference to the mass of structurally or microstructurally distinct parts that contain PFOS or, for textiles or other coated materials, if the amount of PFOS is equal to or higher than 1µg/m² of the coated material.

Reference information for PAHs:

Requirement of ZEK 01.2-08 : Restraining maximum values for products

Parameter	Category 1	Category 2	Category 3
	Materials in contact with foodstuff or materials which are meant to put in the mouth as well as toys for children <36 months.	Materials with foreseeable skin contact >30 s (prolonged skin contact) and toys not covered by category 1.	Materials with foreseeable skin contact <30 s (short time skin contact) or without skin contact.
Benzo[a]pyrene (mg/kg)	<MDL (<0.2)**	1	20
Sum of 16 EPA-PAH (mg/kg)*	<MDL (<0.2)**	10	200

Remark :

* = Only PAH substances >0.2 mg/kg are taken into account while calculating the sum of PAHs

** = In case that the maximum values exceed the limits of category 1, but are within the limits of category 2, one may confirm the suitability of the tested material for contact with foodstuff or oral mucosa by additional specific migration tests of PAH components based on DIN EN 1186ff and §64 LFGB 80.30-1. The conclusion of the migration test results must be made based on food law criteria.

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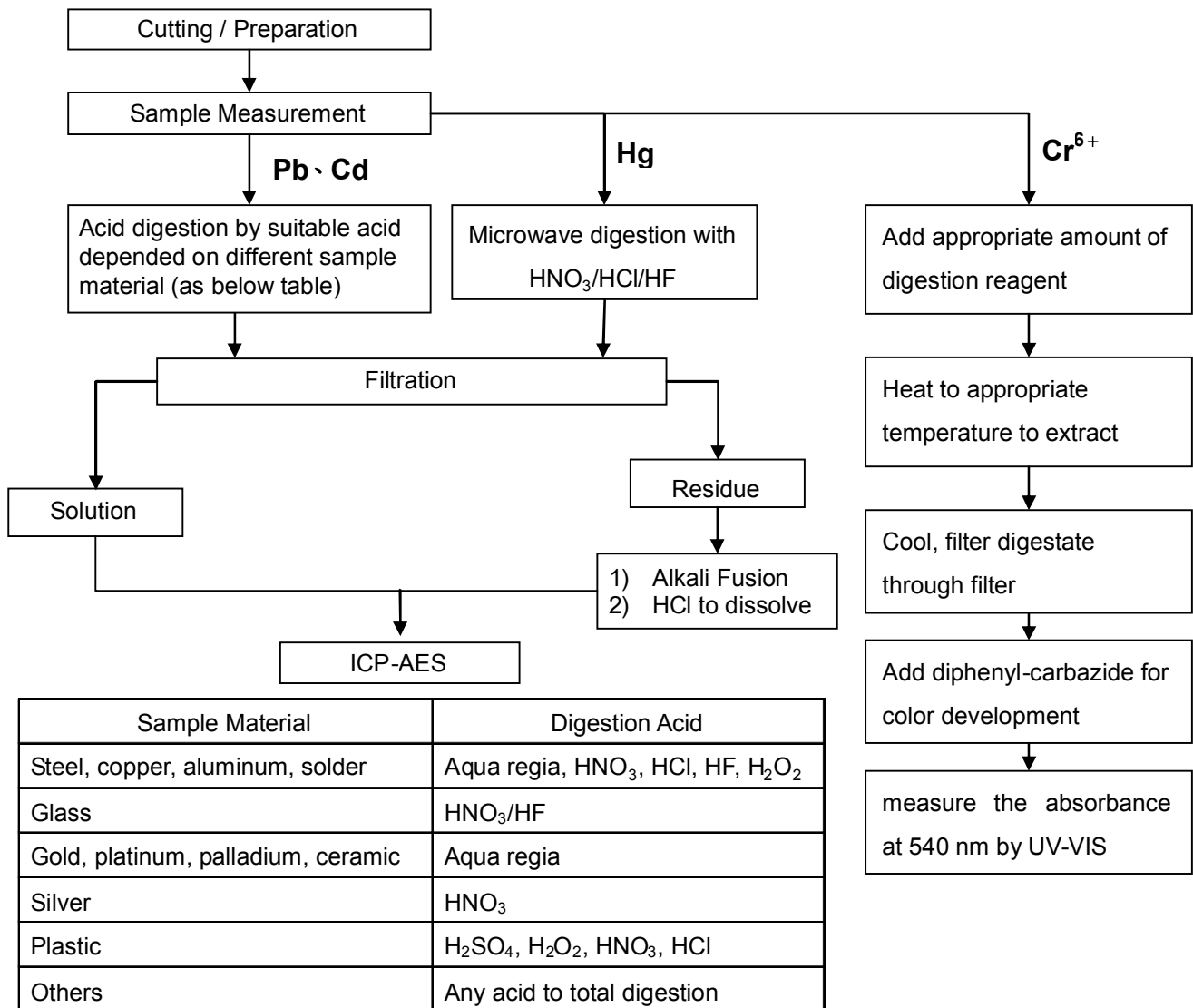
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- 1) These samples were dissolved totally by pre-conditioning method according to below flow chart.
(Cr⁶⁺ test method excluded)
- 2) Name of the person who made measurement: Climbgreat Yang
- 3) Name of the person in charge of measurement: Troy Chang



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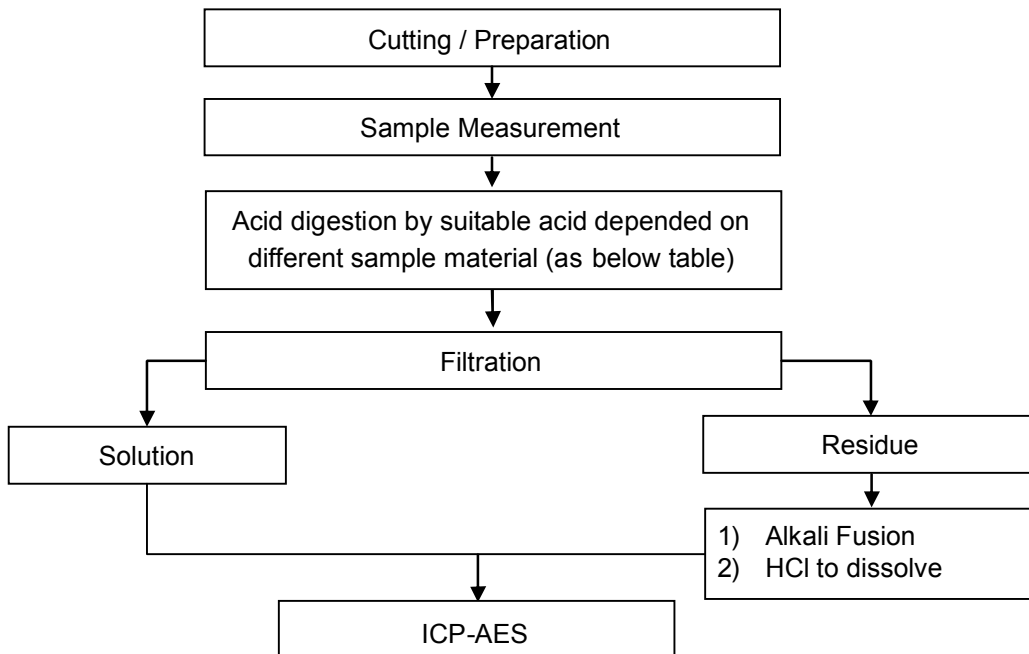
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LITE-ON SEMICONDUCTOR CORP.
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- 1) These samples were dissolved totally by pre-conditioning method according to below flow chart.
- 2) Name of the person who made measurement: Climbgreat Yang
- 3) Name of the person in charge of measurement: Troy Chang

Flow Chart of digestion for the elements analysis performed by ICP-AES



Steel, copper, aluminum, solder	Aqua regia, HNO ₃ , HCl, HF, H ₂ O ₂
Glass	HNO ₃ /HF
Gold, platinum, palladium, ceramic	Aqua regia
Silver	HNO ₃
Plastic	H ₂ SO ₄ , H ₂ O ₂ , HNO ₃ , HCl
Others	Any acid to total digestion

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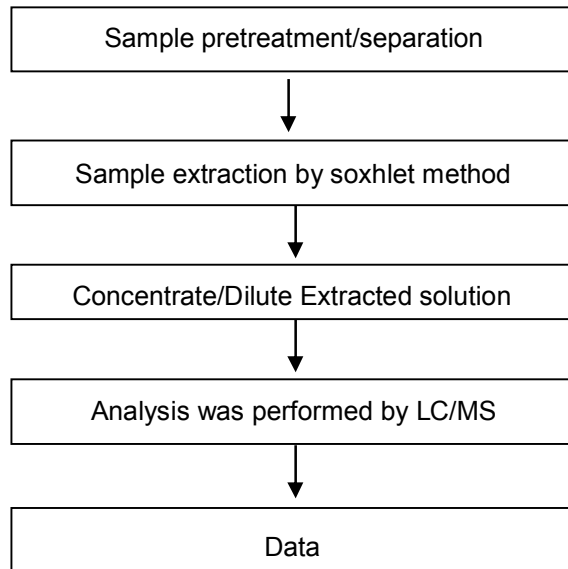
LITE-ON SEMICONDUCTOR CORP.
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Analytical flow chart of Soxhlet extraction (LC/MS) procedure

- 1) Name of the person who made measurement: Lydia Fu
- 2) Name of the person in charge of measurement: Shinjyh Chen

■ Test Items: PFOS/PFOA 、 Benzotriazole



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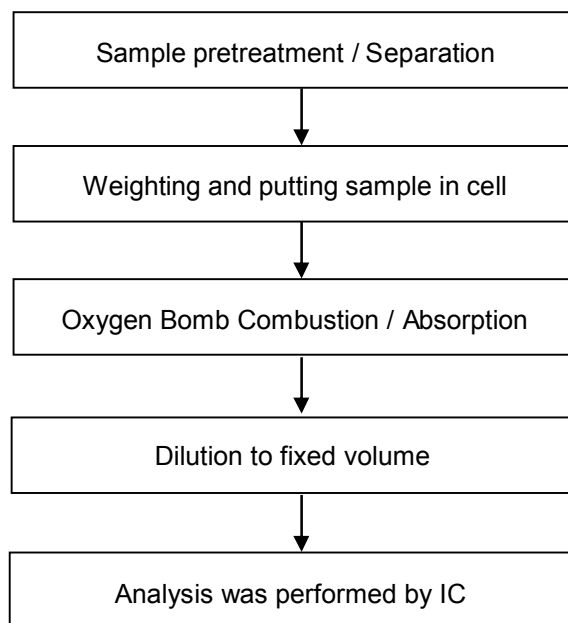
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Analytical flow chart of halogen content

- 1) Name of the person who made measurement: Rita Chen
- 2) Name of the person in charge of measurement: Troy Chang



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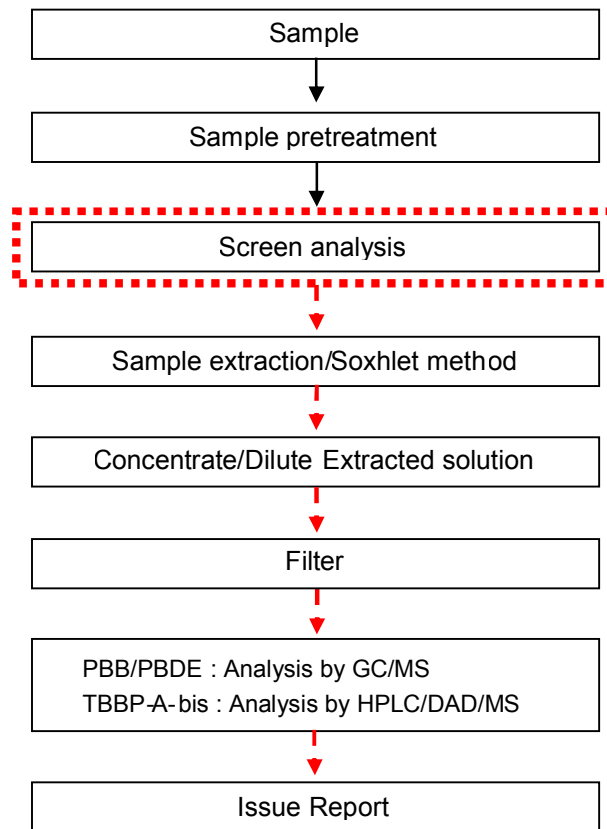
LITE-ON SEMICONDUCTOR CORP.
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Analytical flow chart

- 1) Name of the person who made measurement: Roman Wong
 - 2) Name of the person in charge of measurement: Troy Chang
- Test Items: PBB/PBDE, TBBP-A-bis

First testing process —> Optional screen process Confirmation process - ->



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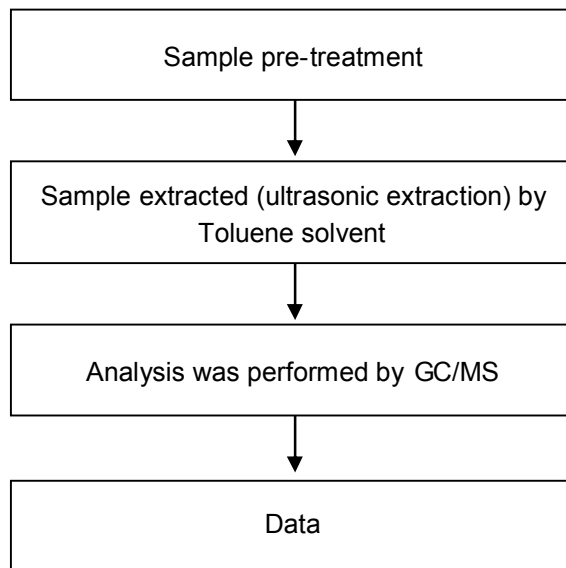
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PAHs (Polynuclear Aromatic Hydrocarbons) analytical flow chart

- 1) Name of the person who made measurement: Andy Shu
- 2) Name of the person in charge of measurement: Shinjyh Chen



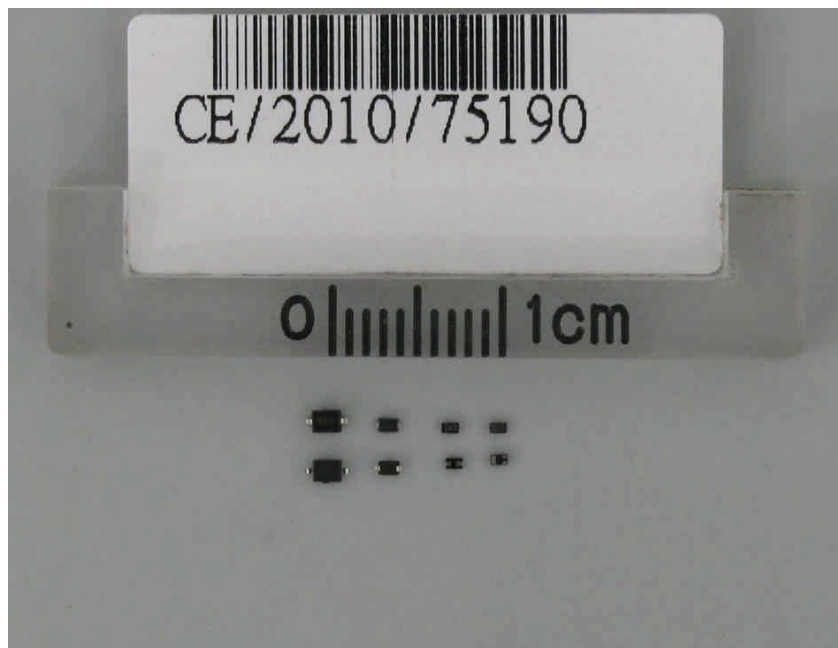
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** End of Report **

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